

Performance characteristics

Frequency range: 1-18GHzSmall signal gain: 15dB

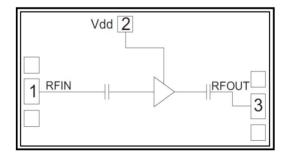
Noise figure: 1.7dB typ. / 2.1dB max.

P-1dB: 17dBm

Power supply: +5V/35mA
Input/Output: 50Ohm
100% on-chip testing

Chip size: 1.6 x 0.95 x 0.09 mm

Functional Block Diagram



Product Introduction

GLA-0118C is a broadband low-noise amplifier chip, with a frequency range of 1GHz to 18GHz, a small signal gain of 15dB, and an in band noise figure of 1.7dB. GLA-0118C1 is powered by a+5V single power supply.

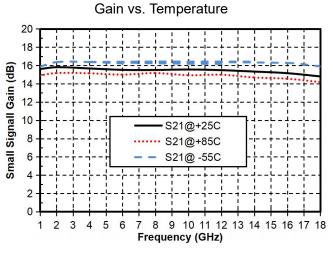
Use restriction parameters ¹		
Maximum leakage voltage	+7V	
Maximum input power	+20dBm	
Working temperature	-55 ~ +85°C	
Storage temperature	-65 ~ +150°C	

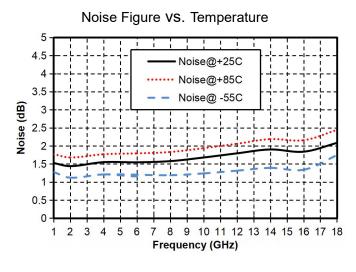
[1] Exceeding any of the above maximum limits may result in permanent damage.

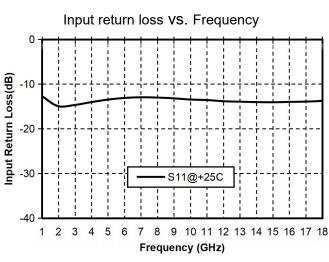
Electrical performance parameters(T _A = +25°C, Vd=+5V)							
Index	Minimum value	Typical value	Maximum value	Unit			
Frequency range	1-18			GHz			
Small signal gain	14.5	15	15.5	dB			
Gain flatness		±0.5		dB			
Noise figure	-	1.7	2.1	dB			
P-1dB	16	17	18.5	dBm			
Psat	18	19	19.5	dBm			
Input return loss		13	-	dB			
Output return Loss	13	19	-	dB			
Static current		35		mA			

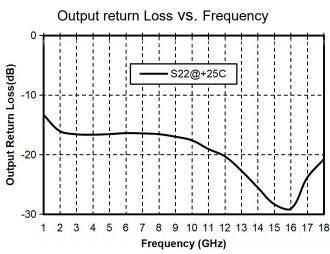


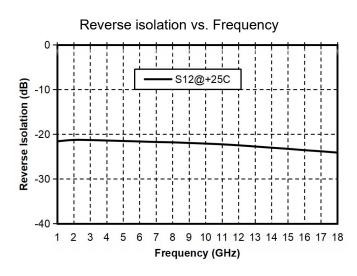
Main indicator testing curve

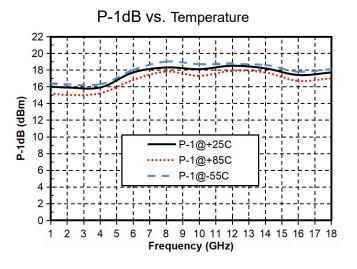






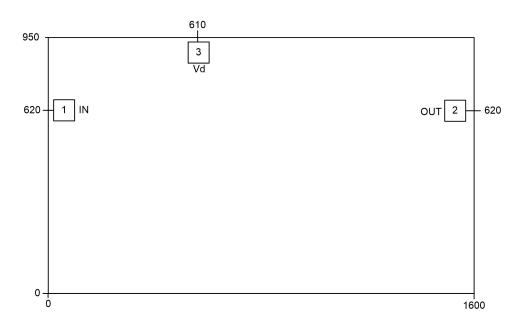








External structure²

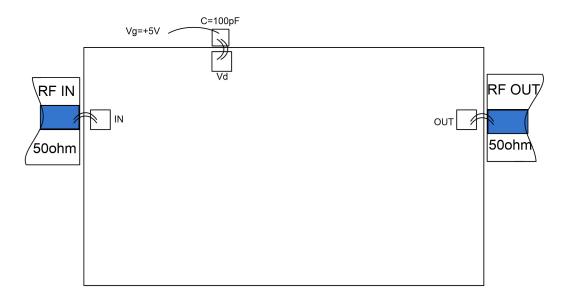


[2] The units in the figure are all millimeters.

Definition of bonding pressure point						
Bond point number	Functional symbols	Function Description	Equivalent circuit			
1	RFIN	RF signal input terminal, no need for DC capacitors.	RFIN O			
2	RFOUT	RF signal output terminal, no need for DC isolation capacitor.				
3	Vd	Amplifier drain bias, requires an external 100pF bypass capacitor.	Vdd			
Chip bottom	GND	The bottom of the chip needs to be well grounded with RF and DC.	OND			



Recommended assembly diagram



Notice

- The chip needs to be stored in a container with anti-static function and stored in a nitrogen environment.
- Attempting to clean the surface of bare chips using wet chemical methods is prohibited.
- Please strictly comply with ESD protection requirements to avoid static damage to bare chips.
- Routine operation: Please use precision pointed tweezers to remove the bare chip. During the operation, avoid tools or fingers touching the surface of the chip.
- Suggestion for mounting operation: Bare chip installation can use AuSn solder eutectic sintering or conductive adhesive bonding process. The installation surface must be clean and flat.
- Sintering process: It is recommended to use AuSn solder sheets with a gold tin ratio of 80/20. The working surface temperature reached 255 °C, and the tool (vacuum chuck) temperature reached 265 °C. When a high-temperature mixed gas (nitrogen to hydrogen ratio of 90/10) is blown onto the chip, the temperature at the top of the tool should be raised to 290 °C. Do not let the chip stay above 320 °C for more than 20 seconds. The friction time should not exceed 3 seconds.
- Bonding process: The amount of conductive adhesive applied should be as small as possible.
 After placing the chip in the installation position, the conductive adhesive can be vaguely visible
 around it. Please follow the information provided by the conductive adhesive manufacturer for
 curing conditions.
- Suggestion for bonding operation: Both spherical or wedge-shaped bonding should be used Φ 0.025mm (1mil) gold wire. Thermal ultrasonic bonding temperature is 150 °C. The pressure of the spherical bonding cutter is 40-50GF, and the pressure of the wedge bonding cutter is 18-22GF. Use as little ultrasonic energy as possible. The bonding process starts at the pressing point on the chip and ends at the packaging (or substrate).

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